


<b>Search Notes</b>  	<b>Application/Control No.</b>  10598729	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  MARIA J LAIOS	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventorship search	6/17/2010	MJL
Text seach in EAST	6/17/2010	MJL
Equivalent cases in JPO and EPO	6/17/2010	MJL
Text search in EAST	12/3/2010	MJL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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